

Call for Papers--Extension
Advances in Econometrics, Volume 29
Essays in Honor of Jerry Hausman

Professor Jerry Hausman has pioneered many areas of econometric research. The aim of this call for papers is to produce a research volume on the theory and practice of econometrics that is linked to, or related to, or inspired by the work of Jerry Hausman.

Possible topics include, but are not limited to:

1. The Hausman specification test
2. Panel data model inference related to the Hausman-Taylor or the Hausman-Hall-Griliches models
3. Instrumental variables and GMM estimation with weak and/or many instruments;
4. Simultaneous equations models

Selected papers will appear in *Advances in Econometrics: Essays in Honor of Jerry Hausman* (Volume 29, 2012). The volume will be edited by Professor Badi Baltagi (Syracuse), Whitney Newey (MIT), Hal White (UC-San Diego) and Carter Hill (LSU).

Please e-mail extended abstracts or complete papers no later than November 15, 2011, to the *Advances in Econometrics* Series Editors:

Professor R. Carter Hill, Louisiana State University: ehill@lsu.edu

Professor Ivan Jeliazkov, University of California, Irvine: ivan@uci.edu

Professor Thomas Fomby, Southern Methodist University: tfomby@smu.edu

Review of manuscripts will commence in December, 2011. The review process will be completed in July, 2012, and accepted articles will appear in print in Fall, 2012. A small conference at LSU for authors and invited guests is tentatively planned for February 17-19, 2012.

Advances in Econometrics, published by Emerald Group Publishing, Ltd., is a research annual whose editorial policy is to publish original articles that contain enough details so that economists and econometricians who are not experts in the topics will find them accessible and useful in their research. To that end, authors should be able to provide, upon request, computer programs and data used in their articles. For more information on the *Advances in Econometrics* series and the titles and contents of previous volumes, see <http://faculty.smu.edu/efomby/aie.htm>.